

Notice of References Cited	Application/Control No. 10/825,616	Applicant(s)/Patent Under Reexamination JANG ET AL.	
	Examiner DANIEL TSEGAYE	Art Unit 2609	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2004/0109526	06-2004	Park et al.	377/064
*	C	US-6,967,639	11-2005	Kanzaki et al.	345/100
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	L	US-			
	M	US-			

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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